

OpensCheck assembly

OTU-DT-OC-160-100

Item 18748



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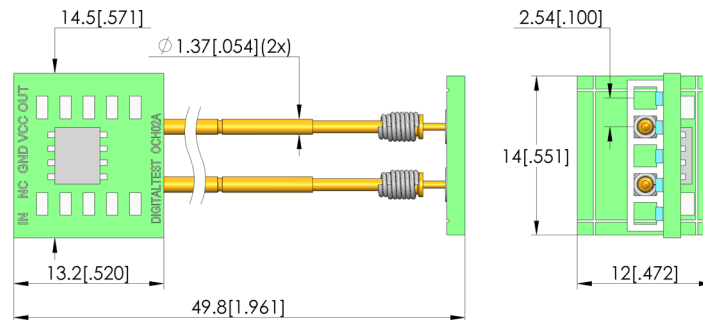
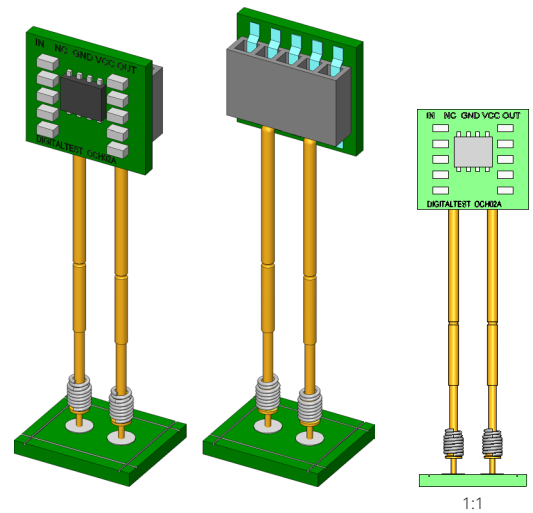
- Component for the Opens test, for capacitive testing of semiconductor chips for open circuits, short circuits and soldering faults
- Suitable for Digitaltest test systems

Application

The OpensCheck test probe is used for capacitive testing of integrated circuits to check the wire-bonded connections inside an integrated circuit for open circuits, short circuits and soldering faults.

Scope of delivery

Electronic plate, sensor plate, and GKS-925 T JA 1000-S test probe



General data

Product group:	Opens tests
Series:	OTU
Type:	Digitaltest opens test
Version:	Opens Check
Accessory type:	Customising accessories
Scope of delivery:	Electronic plate, sensor plate, test probe
Width:	12 mm [.472 in]
Height:	49.8 mm [1.96 in]
Weight:	0.01 kg [.022 lbs]
Min. temperature:	10 °C [50 °F]
Max. temperature:	60 °C [140 °F]
RoHS-compliant:	Yes

Compatible with

Vacuum test fixtures (VA):

VA xxxx/MTSxxx

Technical data

Stroke:	5 mm [.196 in]
Spring force:	1 N [3.59 ozf]
Length:	14 mm [.551 in]
Outer dimensionS (WxDxH):	12 x 14 x 49.8 mm [.472 x .551 x 1.96 in]

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